- **Package Options Include Plastic Small Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs**
- **Dependable Texas Instruments Quality and Reliability**

description

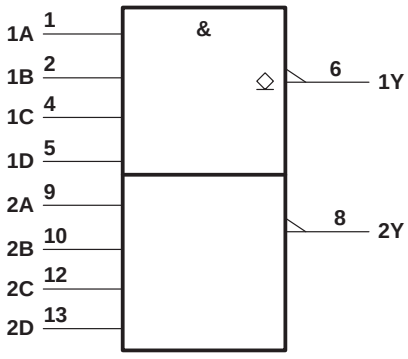
These devices contain two independent 4-input NAND gates. They perform the Boolean functions $Y = \overline{A \bullet B \bullet C \bullet D}$ or $Y = \overline{A}+\overline{B}+\overline{C}+\overline{D}$ in positive logic. The open-collector outputs require pullup resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS22B is characterized for operation over the full military temperature range of 55°C to 125°C. The SN74ALS22B is characterized for operation from 0°C to 70°C.

FUNCTION TABLE
(each gate)

INPUTS				OUTPUT
A	B	C	D	Y
H	H	H	H	L
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H

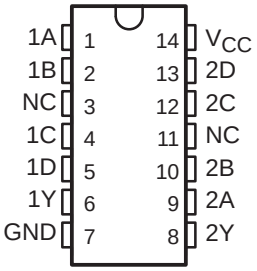
logic symbol†



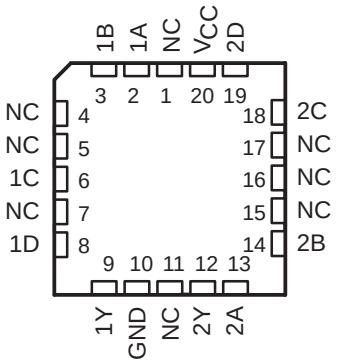
† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

SN54ALS22B . . . J PACKAGE
SN74ALS22B . . . D OR N PACKAGE
(TOP VIEW)

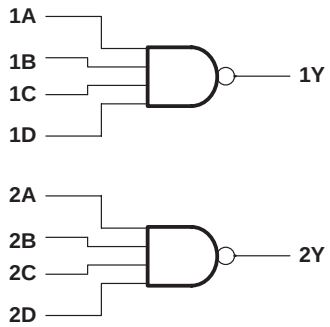


SN54ALS22B . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

logic diagram (positive logic)



PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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5BASIC

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Off-state output voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS22B . . . . . –55°C to 125°C
SN74ALS22B . . . . . 0°C to 70°C
Storage temperature range . . . . . –65°C to 150°C

recommended operating conditions

		SN54ALS22B			SN74ALS22B			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.7			0.8	V
I_{OH}	High-level output current			5.5			5.5	mA
I_{OL}	Low-level output current			4			8	mA
T_A	Operating free-air temperature	–55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS22B			SN74ALS22B			UNIT
			MIN	TYP†	MAX	MIN	TYP†	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = –18 mA			–1.5			–1.5	V
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_{OH}	V_{CC} = 4.5 V,	V_{OH} = 5.5 V			0.1			0.1	mA
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	µA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			–0.1			–0.1	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V		0.22	0.4		0.22	0.4	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V		0.8	1.5		0.8	1.5	mA

† All typical values are at V_{CC} = 5 V, T_A = 25°C.

switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 50 pF, R_L = 2 kΩ, T_A = 25°C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 2 k Ω, T_A = MIN to MAX				UNIT
			'ALS22B	SN54ALS22B		SN74ALS22B		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	35	23	65	23	45	ns
t_{PHL}	Any	Y	8	4	32	4	18	ns

NOTE 1: Load circuit and voltage waveforms are shown in Section 1.

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